Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10625155	MITRA, PRADIP
Examiner	Art Unit
Nguyen, Helen	3736

SEARCHED						
Class		Subclass	Date	Examiner		
600	473-475, 549		7/6/2006	HQN		
Updated	Updated		12/8/2006	HQN		

SEARCH NOTES					
Search Notes	Date	Examiner			
Inventor search performed in PALM	7/6/2006	HQN			
See EAST Search History	7/6/2006	HQN			
STIC Search	7/6/2006	HQN			
Updated	12/8/2006	HQN			

INTERFERENCE SEARCH						
Class	Subclass	Date	Examiner			
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U.S. Patent and Trademark Office Part of Paper No.: 20060630